

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ELEFTHERIADIS ET AL.	
		Examiner Jean W. Désir	Art Unit 2614	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0165271 A1	09-2003	Boon, Choong Seng	382/238
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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